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			C 0 1 2009	Application Number	10/537,173	
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STATEMENT BY APPLICANT (Use as many sheets as necessary)			NT .45/	First Named Inventor	Federico PAVAN	
			PADEMA	Art Unit	3725	
				Examiner Name	Debra M. Sullivan	
Sheet	1	of	1	Attorney Docket Number	07040.0230	

	U.S. PATENTS AND PUBLISHED U.S. PATENT APPLICATIONS					
Examiner Cite		Document Number	Issue or	Name of Patentee or	Pages, Columns, Lines, Where	
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Note: Copies of the U.S. Patent Documents are not Required in IDS filed after October 21, 2004

	FOREIGN PATENT DOCUMENTS						
Examiner Initials	Cite No. ¹	Foreign Patent Document Country Code ³ Number ⁴ Kind Code ⁵ (<i>if known</i>)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	Translation ⁶	
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NON PATENT LITERATURE DOCUMENTS					
Examiner Cite Inc		Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.			
		Hammer, G. E., "Quantitative analysis of sputtered α-+ β-brass surfaces by using Auger electron spectroscopy with principal component analysis-target factor analysis", J. Vac. Sci. Technol. A, Vol. 17, No. 3, May/June 1999, pps. 895-898, American Vacuum Society.			
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Examiner Signature	Date Considered	

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.